



Contribution ID: 110

Type: Poster

## Feasible tuning of microstacking structure and oxidation level in PEDOT: PSS thin films via sequential post-treatment

*Wednesday, 9 December 2020 17:40 (20 minutes)*

Organic semiconductors have attracted intense attention because of their potential use in mechanically flexible, lightweight, and inexpensive electronic devices. Especially, PEDOT:PSS is the most studied conducting polymer system in thermoelectric devices due to its intrinsically high electrical conductivity, low thermal conductivity, and high mechanical flexibility. The energy conversion efficiency of a TE material is evaluated by a dimensionless figure of merit  $ZT$  and defined as  $ZT = S^2\sigma T/k$  where  $S$  is the Seebeck coefficient,  $\sigma$  is the electrical conductivity,  $T$  is the absolute temperature,  $k$  is the thermal conductivity, and  $S^2\sigma$  is defined as the power factor (PF). However, it is generally considered that it is difficult to obtain a high  $ZT$  value of TE materials, due to the fact that the parameters  $S$ ,  $\sigma$ , and  $k$  are interdependent as a function of carrier concentration and hard to be optimized simultaneously. To date, post-treatment is regarded as one promising approach to significantly enhance  $ZT$  values of PEDOT:PSS. Herein, PEDOT:PSS thin films are overcoated with salts/DMSO mixtures in order to optimize their TE performance. Subsequently, the surface morphology and the inner morphology are probed, using atomic force microscopy (AFM) and grazing-incidence wide/small-angle X-ray scattering (GISAXS/GIWAXS), respectively. Additionally, UV-Vis spectroscopy, Raman spectroscopy are used to investigate the mechanism behind for TE performance enhancement.

**Primary authors:** TU, Suo (Institute of Functional Materials); TIAN, Ting; MÜLLER-BUSCHBAUM, Peter (TU München, Physik-Department, LS Funktionelle Materialien)

**Presenter:** TU, Suo (Institute of Functional Materials)

**Session Classification:** Joint poster session of MLZ User Meeting and DN2020

**Track Classification:** UM: Materials Science